

Assess Reliability Parameters of an Electronic Voting Machine using a Neural Network Technique



C. M. Batra, Ritu Gupta, Ekata

Abstract: The structure of Electronic Voting Machine (EVM) is an interconnected network of discrete components that record and count the votes of voters. The EVM system consists of four main subsystems which are Mother board of computer, Voting keys, Database storage system, power supply (AC and DC) along with various conditions of functioning as well as deficiency. The deficiency or failure of system is due to its components (hardware), software and human mismanagement. It is essential to reduce complexity of interconnected components and increase system reliability. Reliability analysis helps to identify technical situations that may affect the system and to predict the life of the system in future. The aim of this research paper is to analyze the reliability parameters of an EVM system using one of the approaches of computational intelligence, the neural network (NN). The probabilistic equations of system states and other reliability parameters are established for the proposed EVM model using neural network approach. It is useful for predicting various reliability parameters and improves the accuracy and consistency of parameters. To guarantee the reliability of the system, Back Propagation Neural Network (BPNN) architecture is used to learn a mechanism that can update the weights which produce optimal parameters values. Numerical examples are considered to authenticate the results of reliability, unreliability and profit function. To minimize the error and optimize the output in the form of reliability using gradient descent method, authors iterate repeatedly till the precision of 0.0001 error using MATLAB code. These parameters are of immense help in real time applications of Electronic Voting Machine during elections.

Keywords: Back Propagation algorithm, EVM, Gradient descent method, Human failure, Neural Network approach, Neural weights, Profit function, Reliability, unreliability.

I. INTRODUCTION

To guarantee the privilege of the right to vote of the citizens, the electoral procedure with security and integrity is a fundamental condition of any nation. According to the People's Representation Act of 1951 and under article 19 (1) (a) of the Constitution of India, voting is a constitutional and fundamental right. Elections in India are conducted almost

Revised Manuscript Received on July 10, 2020.

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entirely using electronic voting machines (EVMs) built over the past two decades. As India is a democratic nation, these devices have been praised for its easy designing, handling and reliability [1]-[2]. But several specifications of machineries design and complexity of system do not disclose, that may cause degradation in functioning or failure of the system [4]. Some other reasons of failure of system are human mishandling. To solve the reliability problems, it is necessary to identify hypotheses/ constraints of dependencies or interdependencies of units/ components of the system [3][6]. To increase the system reliability, standby unit(s) with/ without waiting time to repair is appended [8]. We have already studied and analyze reliability parameters of these type of systems in past, using the technique of supplementary variables. Numerous studies on reliability and profit of systems have been carried out to analyze the behavior of the system, with respect to time. Several reliability parameters of a multi-component complex system under common cause failure, failure due to human error etc. have been studied by renowned researchers [16]. There are many methodologies/ techniques used to evaluate the system reliability. Some of these are Petri nets, supplementary variable technique, stochastic reward nets, and regenerative point technique etc. [5], [7]-[9]. All of these conventional methods to evaluate the reliability parameters precisely, but the current demand is to update the output at the extend of optimization and minimization of errors.

Neural network (NN) learning algorithm has been designed in 1943 by a neurophysiologist, Warren McCulloch and a young mathematician, Walter Pitts [15]. The basic structure of NN relies on the biological structure of neurons in human brain to recognize the input patterns associated with their output. As well as, neural network is dynamic and predict new outcomes from past experience at high speed and minimize the errors. In view of this, supervised learning of neural network approach can be utilized to solve the mathematical model of multi-component system and optimize the results as required by system designers. A neural network involves simple processing elements, neurons that are well connected by weighted synaptic links and form network architecture (Figure 1). Authors proposed architecture of neural network comprises three layers, which incorporate the following: Input layer that takes input in context of problem;

Hidden layer particular to update the weights in between input and output layers and

Output layer manifests the optimized results to the supervisor. It presents a complex global behavior,



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determined by the connections between the input elements, processing elements and output parameters along the learning mechanism to train the system. The learning algorithms characterize the process of adjusting/updating the weights by adopting activation function and minimizing the errors of the weights using error correction gradient descent method in back propagation algorithm. The back propagation algorithm in neural network (BPNN) was introduced in 1970s and used for training the system network and minimizing the error up to required accuracy. Now, Neural Networks (NN) has been applied in evaluation of reliability parameters as well as simulates its growth [10]-[12]. In this paper, we propose an NN based reliability growth model based on EVM system. The results shown in numerical example includes initial values and optimized values of the reliability, unreliability, and profit function. The proposed BPNN approach is a promising tool for stochastic analysis of system reliability by minimizing the error up to desired negligible accuracy and optimizes the results.

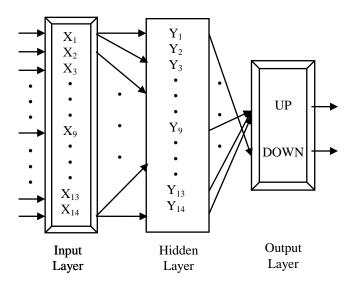


Fig. 1: Neural Networks Structure

II. SYSTEM DESCRIPTION

From many decades, countries are governed by their citizens. People have authority to choose their governing bodies those serve the country as well as save their rights i.e. Democracy. An election is a procedure by which representative of people elected. Elections are a defining feature of democratic government since 17th century [1]-[2]. *Voting* is, the only, method for people to elect their representative by collective decision and to express an opinion. In earlier time, name of all candidates, who wanted to serve the country, written on a paper with their specific symbol i.e. ballot paper. Voters, people who have right to vote; cast the ballot paper for their chosen candidates. Electorate can directly make decisions after collecting and counting all casted ballots and declare the constituency. This manual process was time taking and sometimes became the reason of riot. In view of all these problems, Electronic voting machine is introduced that uses electronic means to take care of casting and counting of votes. Input of votes, recording it, data encryption, counting of votes and transmission to main server is a rapid process. E-voting machine may be used standalone by the connection with computers and internet. It can convert e-report to tabulated results easily in less time and with more accuracy [13]-[14].

Electronic Voting Machine consists of

- 1. Subsystem 1 (A)- Mother Board: It consists of Micro controller (Mc), Integrated Circuits, latch and decoders(D), buzzer(B), LCD display, LED green(LED), RAM reset (Re) and RAM check (Rc).
- 2. Subsystem 2 (V)- Voting Kit: It connects with subsystem A through wires (W)
- 3. Subsystem 3 (DSS)- Database Storage System: It consists of two units viz. personal computer (PC) and scanner(SCAN) and connected to subsystem A through interface (a parallel port)
- 4. Subsystem 4 (PS)- Power Supply: There are two type of power supplies i.e. through alternating current (PSAC) and DC (PSDC)

The unit Mc is connected to B, LCD and LED through wires. The integrated circuit is connected to Re and Rc. It is assumed that subsystems Mc, IC's and D are non volatile, i.e. they are in operable state whenever the system is required. Subsystem V is connected to unit Mc, B, LCD and LED through wires. Subsystem DSS consists of two units PC & Scanner that is connected to unit IC's, Re and Rc through interface (a parallel port). Wires connect all the subsystems and their units. Fixed power supply is given to the system (Figure 2). Failure of B and LCD reduces the efficiency of the system, causing a degraded state while failure of both units, results into a non operable state of the system. The whole complex system can also be in a total failure state due to failure of unit LED / Rc/ Re or any key in subsystem B / PC/ SCAN and due to human error.

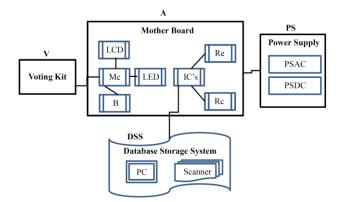


Fig 2: Block Diagram



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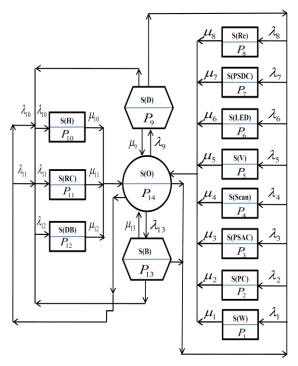


Fig. 3: Transition State Diagram

Authors established the probabilistic equation of mathematical model for electronic voting machine system from transition state diagram and evaluate reliability parameters using neural network technique. All hardware/human failures and repairs are exponentially distributed and treated as synaptic weights in NN. Rajasekaran et. al. [10] and many others described the back propagation algorithm in neural networks to improve the results. The learning mechanism in Back propagation of neural network is used to update the weights in several iterations as these parameters produce better results. .m file code in MATLAB has been developed to predict the reliability, unreliability and profit function using Back propagation neural network technique.

III. ASSUMPTIONS

- 1. Initially, all subsystems of system are good.
- 2. During the degraded state of the system, failure of unit B/ LCD may cause the failure of other units.
- The system fails completely due to failure of LED, Re, Rc, subunits PC and scanner and failure of units B and LCD simultaneously.
- 4. Since the units are connected through wire, so any disconnection or any fuse wire may result in breakdown of the machine (system).
- 5. The system may also fail if there is a power cut of DC or AC supply of the machine.
- 6. System fails completely due to mishandling i.e. a human error
- All failures and repairs of system are exponentially distributed.
- 8. Failures and repairs of the system are established as synaptic weights.
- 9. The repaired subsystem(s) function as new.

IV. NOTATIONS

$$P_i(t)$$
 i^{th} state Probability at any time t , $i=1,2,\ldots,14$ $P_i(t+\Delta t)$ i^{th} state Probability at time $(t+\Delta t)$, $i=1,2,3\ldots,14$ λ_i Hardware failure, due to i th unit failure, $i=1,2,\ldots,13$ μ_i i th unit Hardware repair, $i=1,2,\ldots,13$

V. SOLUTION OF THE MODEL

The reliability and profit function of the system have been explored by neural network approach. The various states of system can be described using probabilistic phenomenon. These system state probabilities are as follows:

$$P_1(t + \Delta t) = (1 - \mu_1 \Delta t)P_1(t) + \lambda_1 \Delta t P_9(t)$$

$$+ \lambda_1 \Delta t P_{13}(t) + \lambda_1 \Delta t P_{14}(t)$$
(1)

$$P_{2}(t + \Delta t) = (1 - \mu_{2}\Delta t)P_{2}(t) + \lambda_{2}\Delta tP_{9}(t) + \lambda_{2}\Delta tP_{13}(t) + \lambda_{2}\Delta tP_{14}(t)$$
(2)

$$P_3(t + \Delta t) = (1 - \mu_3 \Delta t) P_3(t) + \lambda_3 \Delta t P_9(t)$$

$$+ \lambda_3 \Delta t P_{13}(t) + \lambda_3 \Delta t P_{14}(t)$$
(3)

$$P_4(t + \Delta t) = (1 - \mu_4 \Delta t)P_4(t) + \lambda_4 \Delta t P_9(t) + \lambda_4 \Delta t P_{14}(t) + \lambda_4 \Delta t P_{14}(t)$$
(4)

$$P_{5}(t + \Delta t) = (1 - \mu_{5}\Delta t)P_{5}(t) + \lambda_{5}\Delta tP_{9}(t) + \lambda_{5}\Delta tP_{14}(t)$$

$$(5)$$

$$P_{6}(t + \Delta t) = (1 - \mu_{6}\Delta t)P_{6}(t) + \lambda_{6}\Delta t P_{9}(t) + \lambda_{6}\Delta t P_{13}(t) + \lambda_{6}\Delta t P_{14}(t)$$

$$(6)$$

$$P_{7}(t + \Delta t) = (1 - \mu_{7} \Delta t)P_{7}(t) + \lambda_{7} \Delta t P_{9}(t) + \lambda_{7} \Delta t P_{13}(t) + \lambda_{7} \Delta t P_{14}(t)$$

$$(7)$$

$$P_{8}(t + \Delta t) = (1 - \mu_{8}\Delta t)P_{8}(t) + \lambda_{8}\Delta tP_{9}(t) + \lambda_{9}\Delta tP_{14}(t)$$
(8)

$$P_{9}(t+\Delta t) = \begin{pmatrix} 1 - \begin{pmatrix} \lambda_{1} + \lambda_{2} + \lambda_{3} + \lambda_{4} + \lambda_{5} \\ + \lambda_{6} + \lambda_{7} + \lambda_{8} + \lambda_{10} \\ + \lambda_{11} + \lambda_{12} + \mu_{9} \end{pmatrix} \Delta t \end{pmatrix} P_{9}(t) + \lambda_{9} \Delta t P_{14}(t)$$

$$(9)$$

$$P_{10}(t + \Delta t) = (1 - \mu_{10}\Delta t)P_{10}(t) + \lambda_{10}\Delta tP_{9}(t) + \lambda_{10}\Delta tP_{13}(t) + \lambda_{10}\Delta tP_{14}(t)$$
(10)

$$P_{11}(t + \Delta t) = (1 - \mu_{11}\Delta t)P_{11}(t) + \lambda_{11}\Delta t P_{9}(t) + \lambda_{11}\Delta t P_{13}(t) + \lambda_{11}\Delta t P_{14}(t)$$
(11)

$$P_{12}(t + \Delta t) = (1 - \mu_{12}\Delta t)P_{12}(t) + \lambda_{12}\Delta t P_{9}(t) + \lambda_{12}\Delta t P_{13}(t)$$
(12)



Assess Reliability Parameters of an Electronic Voting Machine using a Neural Network Technique

$$P_{13}(t + \Delta t) = \begin{pmatrix} \lambda_{1} + \lambda_{2} + \lambda_{3} + \lambda_{4} + \lambda_{5} \\ + \lambda_{6} + \lambda_{7} + \lambda_{8} + \lambda_{10} \\ + \lambda_{11} + \lambda_{12} + \mu_{13} \end{pmatrix} \Delta t P_{9}(t) \\ + \lambda_{13} \Delta t P_{14}(t)$$

$$P_{14}(t + \Delta t) = \begin{pmatrix} 1 - \begin{pmatrix} \lambda_{1} + \lambda_{2} + \lambda_{3} + \lambda_{4} + \lambda_{5} + \lambda_{6} + \lambda_{7} \\ + \lambda_{8} + \lambda_{9} + \lambda_{10} + \lambda_{11} + \lambda_{13} \end{pmatrix} \Delta t P_{14}(t) \\ + \mu_{1} \Delta t P_{1}(t) + \mu_{2} \Delta t P_{2}(t) + \mu_{3} \Delta t P_{3}(t) \\ + \mu_{4} \Delta t P_{4}(t) + \mu_{5} \Delta t P_{5}(t) + \mu_{6} \Delta t P_{6}(t) \\ + \mu_{7} \Delta t P_{7}(t) + \mu_{8} \Delta t P_{8}(t) + \mu_{9} \Delta t P_{9}(t) \\ + \mu_{10} \Delta t P_{10}(t) + \mu_{11} \Delta t P_{11}(t) + \mu_{12} \Delta t P_{12}(t) \\ + \mu_{13} \Delta t P_{13}(t)$$

$$(14)$$

According to transition state diagram (Figure 3), weights of synaptic links are as follows:

$$\begin{aligned} w_{11} &= 1 - \mu_1 \Delta t, \ w_{1(14)} &= \mu_1 \Delta t, \\ w_{12} &= w_{13} = w_{14} = w_{15} = w_{16} = w_{17} = 0 \\ w_{18} &= w_{19} = w_{1(10)} = w_{1(11)} = w_{1(12)} = w_{1(13)} = 0 \\ w_{21} &= 0, \quad w_{22} = 1 - \mu_2 \Delta t, \quad w_{2(14)} = \mu_2 \Delta t, \\ w_{23} &= w_{24} = w_{25} = w_{26} = w_{27} = w_{28} = 0 \\ w_{29} &= w_{2(10)} = w_{2(11)} = w_{2(12)} = w_{2(13)} = 0 \\ w_{31} &= w_{32} = 0, \quad w_{3(14)} = \mu_3 \Delta t, \\ w_{33} &= 1 - \mu_3 \Delta t, \\ w_{34} &= w_{35} = w_{36} = w_{37} = w_{38} = 0 \\ w_{39} &= w_{3(10)} = w_{3(11)} = w_{3(12)} = w_{3(13)} = 0 \\ w_{41} &= w_{42} = w_{43} = 0, \quad w_{4(14)} = \mu_4 \Delta t, \\ w_{45} &= w_{46} = w_{47} = w_{48} = 0 \\ w_{49} &= w_{4(10)} = w_{4(11)} = w_{4(12)} = w_{4(13)} = 0 \\ w_{55} &= 1 - \mu_5 \Delta t, \quad w_{5(13)} = \mu_5 \Delta t, \\ w_{51} &= w_{52} = w_{53} = w_{54} = w_{56} = w_{57} = 0 \\ w_{58} &= w_{59} = w_{5(10)} = w_{5(11)} = w_{5(12)} = w_{5(13)} = 0 \\ w_{66} &= 1 - \mu_6 \Delta t, \quad w_{6(13)} = \mu_6 \Delta t, \\ w_{61} &= w_{62} = w_{63} = w_{64} = w_{65} = w_{67} = 0 \\ w_{68} &= w_{69} = w_{6(10)} = w_{6(11)} = w_{6(12)} = w_{6(13)} = 0 \\ w_{77} &= 1 - \mu_7 \Delta t, \quad w_{7(13)} = \mu_7 \Delta t, \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{71} &= w_{72} = w_{73} = w_{74} = w_{75} = w_{76} = 0 \\ w_{72} &= w_{73} = w_{74} = w_{75} = w_{76} = 0$$

$$w_{81} = w_{82} = w_{83} = w_{84} = w_{85} = w_{86} = 0$$

$$w_{87} = w_{89} = w_{8(10)} = w_{8(11)} = w_{8(12)} = w_{8(13)} = 0$$

$$w_{91} = \lambda_1 \Delta t, \ w_{92} = \lambda_2 \Delta t, \ w_{93} = \lambda_3 \Delta t,$$

$$w_{94} = \lambda_4 \Delta t, \ w_{95} = \lambda_5 \Delta t, \ w_{96} = \lambda_6 \Delta t,$$

$$w_{97} = \lambda_7 \Delta t, \ w_{98} = \lambda_8 \Delta t,$$

$$w_{99} = 1 - \begin{pmatrix} \lambda_1 + \lambda_2 + \lambda_3 + \lambda_4 + \lambda_5 + \lambda_6 + \lambda_7 \\ + \lambda_8 + \lambda_{10} + \lambda_{11} + \lambda_{12} + \mu_9 \end{pmatrix} \Delta t$$

$$w_{9(10)} = \lambda_{10} \Delta t, \ w_{9(11)} = \lambda_{11} \Delta t,$$

$$w_{9(12)} = \lambda_{12} \Delta t, \ w_{9(14)} = \mu_{9} \Delta t,$$

$$w_{(10)1} = w_{(10)2} = w_{(10)3} = w_{(10)4} = w_{(10)5} = w_{(10)6} = 0$$

$$w_{(10)7} = w_{(10)8} = w_{(10)9} = w_{(10)4} = w_{(10)5} = w_{(10)(13)} = 0$$

$$w_{(10)10} = 1 - \mu_{10} \Delta t, \ w_{(10)4} = \mu_{10} \Delta t,$$

$$w_{(11)1} = w_{(11)2} = w_{(11)3} = w_{(11)4} = w_{(11)5} = w_{(11)6} = 0$$

$$w_{(11)7} = w_{(11)8} = w_{(11)9} = w_{(11)(10)} = w_{(11)(12)} = w_{(11)(13)} = 0$$

$$w_{(11)(11)} = 1 - \mu_{11} \Delta t, \ w_{(11)(14)} = \mu_{11} \Delta t,$$

$$w_{(12)1} = w_{(12)2} = w_{(12)3} = w_{(12)4} = w_{(12)5} = w_{(12)6} = 0$$

$$w_{(12)7} = w_{(12)8} = w_{(12)9} = w_{(12)(10)} = w_{(12)(11)} = w_{(12)(13)} = 0$$

$$w_{(12)(12)} = 1 - \mu_{12} \Delta t, \ w_{(13)4} = \mu_{12} \Delta t,$$

$$w_{(13)4} = \lambda_4 \Delta t, \quad w_{(13)5} = \lambda_5 \Delta t,$$

$$w_{(13)4} = \lambda_4 \Delta t, \quad w_{(13)5} = \lambda_5 \Delta t,$$

$$w_{(13)(10)} = \lambda_{10} \Delta t, \quad w_{(13)(11)} = \lambda_{11} \Delta t,$$

$$w_{(13)(12)} = \lambda_{12} \Delta t, \quad w_{(13)(11)} = \lambda_{11} \Delta t,$$

$$w_{(13)(13)} = 1 - \begin{pmatrix} \lambda_1 + \lambda_2 + \lambda_3 + \lambda_4 + \lambda_5 + \lambda_6 + \lambda_7 \\ + \lambda_8 + \lambda_{10} + \lambda_{11} + \lambda_{12} + \mu_{13} \end{pmatrix} \Delta t$$

$$w_{(14)1} = \lambda_1 \Delta t, \quad w_{(14)2} = \lambda_2 \Delta t, \quad w_{(14)3} = \lambda_3 \Delta t,$$

$$w_{(14)4} = \lambda_4 \Delta t, \quad w_{(14)5} = \lambda_5 \Delta t, \quad w_{(14)6} = \lambda_6 \Delta t,$$

$$w_{(14)1} = \lambda_1 \Delta t, \quad w_{(14)2} = \lambda_2 \Delta t, \quad w_{(14)3} = \lambda_3 \Delta t,$$

$$w_{(14)1} = \lambda_1 \Delta t, \quad w_{(14)2} = \lambda_2 \Delta t, \quad w_{(14)3} = \lambda_3 \Delta t,$$

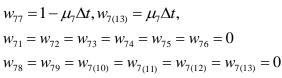
$$w_{(14)10} = \lambda_1 \Delta t, \quad w_{(14)2} = \lambda_2 \Delta t, \quad w_{(14)3} = \lambda_3 \Delta t,$$

$$w_{(14)10} = \lambda_1 \Delta t, \quad w_{(14)10} = \lambda_1 \Delta t, \quad w_{(14)10} = \lambda_1 \Delta t,$$

$$w_{(14)10} = \lambda_1 \Delta t, \quad w_{(14)10} = \lambda_1 \Delta t, \quad w_{(14)10} = \lambda_1 \Delta t,$$

$$w_{(14)10} = \lambda_1 \Delta t, \quad w_{(14)2} = \lambda_2 \Delta t, \quad w_{(14)3} = \lambda_3 \Delta t,$$

$$w_{(14)10} =$$



$$w_{88} = 1 - \mu_8 \Delta t, w_{8(13)} = \mu_8 \Delta t,$$



 $w_{(14)(14)} = 1 - \begin{pmatrix} \lambda_1 + \lambda_2 + \lambda_3 + \lambda_4 + \lambda_5 + \lambda_6 + \lambda_7 \\ + \lambda_8 + \lambda_9 + \lambda_{10} + \lambda_{11} + \lambda_{13} \end{pmatrix} \Delta t$



VI. BACK PROPAGATION NEURAL NETWORK ALGORITHM OF THE SYSTEM

Step 1: Assume total number of inputs and outputs

Step 2: Set desired output

Step 3: Input the number of neurons in hidden layer.

Step 4: Initialize the synaptic link's weight matrices

[W]: Weights of synaptic links connecting input and hidden layer.

[V]: Weights of synaptic links connecting hidden and output layer.

Step 5: Evaluate inputs of hidden layer using

 $I_h = W^{T_*}O_i$

[W^T]: Transpose of weight matrix connecting input and hidden layer.

[O_i]: Output of Input Laver

Step 6: Evaluate output of hidden layer using Sigmoidal

function, i.e.
$$O_h = \left\{ \frac{1}{1 + e^{-I_{h_i}}} \right\}$$

[V^T]: Transpose of weight matrix connecting hidden and output layer.

[O_h]: Output of hidden Layer

Step 8: Evaluate output of output layer using Sigmoidal

function, i.e.
$$O_o = \left\{ \frac{1}{1 + e^{-I_{0i}}} \right\}$$

Step 9: Compare evaluated output (in step 8) with

Target output (in step 2), then evaluate the error

Step 10: If error < tolerance

Then End the learning process.

Update weight matrices [V] and [W] using error correction gradient descent method

Increment the epochs by 1 go to Step 5

else End the learning process

Inputs, X_i , demonstrate in Neural network structure (Figure 1), express by following equations:

$$X_i = P_i(t)$$
; where $i = 1, 2, ..., 14$...(15)

The outputs of neurons, Y_i , of considered system represent by following equations:

$$Y_i = P_i(t + \Delta t)$$
, where $i = 1, 2, ..., 14$... (16)

Using transition states diagram (Figure 3), authors established following output equations:

$$Y_1 = w_{11}X_1 + w_{01}X_9 + w_{(13)1}X_{(13)} + w_{(14)1}X_{14}$$
 (17)

$$Y_2 = w_{22}X_2 + w_{92}X_9 + w_{(13)2}X_{(13)} + w_{(14)2}X_{14}$$
 (18)

$$Y_3 = w_{33}X_3 + w_{93}X_9 + w_{(13)3}X_{(13)} + w_{(14)3}X_{14}$$
 (19)

$$Y_4 = W_{44}X_4 + W_{94}X_9 + W_{(13)4}X_{(13)} + W_{(14)4}X_{14}$$
 (20)

$$Y_5 = w_{55}X_5 + w_{95}X_9 + w_{(13)5}X_{(13)} + w_{(14)5}X_{14}$$
 (21)

$$Y_6 = W_{66}X_1 + W_{96}X_9 + W_{(13)6}X_{(13)} + W_{(14)6}X_{14}$$
 (22)

$$Y_7 = w_{77}X_7 + w_{97}X_9 + w_{(13)7}X_{(13)} + w_{(14)7}X_{14}$$
 (23)

$$Y_8 = w_{88}X_8 + w_{98}X_9 + w_{(13)8}X_{13} + w_{(14)8}X_{14}$$
 (24)

$$Y_9 = w_{99}X_9 + w_{(14)9}X_{14}$$

(25)

$$Y_{(10)} = w_{(10)(10)} X_{(10)} + w_{9(10)} X_9 + w_{(13)(10)} X_{(13)} + w_{(14)(10)} X_{14}$$
(26)

$$Y_{(11)} = w_{(11)(11)} X_{(11)} + w_{9(11)} X_9 + w_{(13)(11)} X_{(13)} + w_{(14)(11)} X_{(14)}$$

$$Y_{(12)} = W_{(12)(12)}X_{(12)} + W_{9(12)}X_9 + W_{(13)(12)}X_{(13)}$$
 (28)

$$Y_{13} = w_{(10)(13)} X_{13} + w_{(14)(13)} X_{14}$$

$$Y_{14} = w_{(14)(14)} X_{14} + w_{1(14)} X_1 + w_{2(14)} X_2 + w_{3(14)} X_3$$
(29)

$$+ w_{4(14)} X_4 + w_{5(14)} X_5 + w_{6(14)} X_6 + w_{7(14)} X_7$$

$$+ w_{8(14)}X_8 + w_{9(14)}X_9 + w_{(10)(14)}X_{10} + w_{(11)(14)}X_{11} + w_{(12)(14)}X_{12} + w_{(13)(14)}X_{13}$$
(30)

Transition states, whether the system is in working mode or in failure mode, can be classified as up and down states respectively. The up and down state probabilities of the system state combine distinctly from (17)-(30) and represent as follows:

The reliability and profit function of the considered system can be expressed as:

Reliabilit
$$y = Y_9 + Y_{13} + Y_{14}$$
 ...(33)

$$G(t) = C_1 \times P_{up} - C_2 \times t \qquad \dots (34)$$

where C_1 : revenue cost

 C_2 : repair cost per unit time

P_{up}(t): Probability of operable states



Assess Reliability Parameters of an Electronic Voting Machine using a Neural Network Technique

VII. NUMERICAL EXAMPLE

Following data for repairable system are assumed by authors, to analyze the results

$$\mu_i = 1; \lambda_i = 0.01; a = 0.8$$

Equation (32) and (33) yields unreliability and reliability of the system by BP neural network technique. Table I and Figure 4 exhibit the desired reliability, i.e. approximate 1, up to 10⁻⁴ error tolerance in tabular and graphical form respectively. Figure 5 shows the corresponding unreliability.

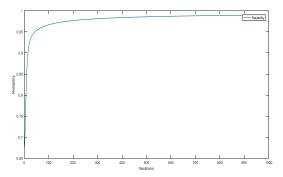


Fig. 4: Optimize Reliability with Iteration

Table I. Reliability with iteration

Iterat ions	Pup	Pdown	Total =Pup+Pdown
1	0.6748	0.5001	1.1749
25	0.9325	0.0218	0.9543
50	0.9532	0.0191	0.9723
100	0.9669	0.0165	0.9834
150	0.9731	0.0146	0.9877
200	0.9769	0.0133	0.9902
250	0.9794	0.0123	0.9917
300	0.9813	0.0116	0.9929
350	0.9828	0.0108	0.9936
400	0.984	0.0102	0.9942
450	0.9849	0.0097	0.9946
500	0.9858	0.0092	0.995
550	0.9865	0.0089	0.9954
600	0.9871	0.0085	0.9956
650	0.9876	0.0082	0.9958
700	0.9881	0.008	0.9961
750	0.9885	0.0077	0.9962
800	0.9889	0.0075	0.9964
850	0.9893	0.0073	0.9966
900	0.9896	0.0071	0.9967
950	0.9899	0.0069	0.9968
968	0.99	0.0068	0.9968

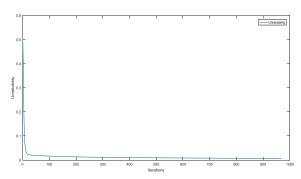


Fig. 5: Minimize Unreliability with Iteration

One can obtain the various values of the profit function of the system using equation (34). Consider the revenue cost C_1 =100 units and different values of repair cost, $C_2 = 30, 50, 80$ units for comparison and analyzing the profit function. Profit function values are evaluated that are listed in Table II and represented graphically in Figure 6.

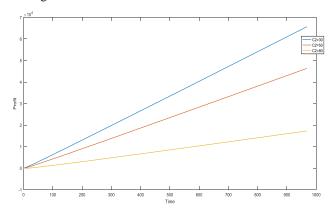


Fig 6: Time vs Comparative profit

Table II. Time Vs Comparative profit

Table II. Time vs Comparative profit						
Time/	Profit Function Value (units)					
epochs	C2=80	C2=50	C2=30			
1	-12.5185	17.4815	37.4815			
50	483.8873	1983.8873	2983.8873			
100	1290.4979	4290.4979	6290.4979			
150	2142.3422	6642.3422	9642.3422			
200	3018.1094	9018.1094	13018.1094			
250	3909.2754	11409.2754	16409.2754			
300	4811.4027	13811.4027	19811.4027			
350	5721.8351	16221.8351	23221.8351			
400	6638.8349	18638.8349	26638.8349			
450	7561.1926	21061.1926	30061.1926			
500	8488.0270	23488.0270	33488.0270			
550	9418.6726	25918.6726	36918.6726			
600	10352.6128	28352.6128	40352.6128			
650	11289.4370	30789.4370	43789.4370			
700	12228.8127	33228.8127	47228.8127			
750	13170.4659	35670.4659	50670.4659			
800	14114.1682	38114.1682	54114.1682			
850	15059.7266	40559.7266	nce 7539.7266			

Retrieval Number: E1056069520/2020©BEIESP DOI: 10.35940/ijeat.E1056.089620

Journal Website: www.ijeat.org

Published By: Blue Eyes Intelligence Engineering



900	16006.9762	43006.9762	61006.9762
950	16955.7749	45455.7749	64455.7749
968	17297.6974	46337.6974	65697.6974

VIII. CONCLUSION

In current scenario, neural network's applications associate with diverse fields such as image processing, optimization of system working, machine learning etc.

It consists of many techniques; one of them is back propagation neural networks to optimize the output of the system. EVM is an electronic machine that takes care of casting and counting of votes during election process of any democratic country. It incorporates many discrete components with reliability factors. Determining the accuracy of the system reliability is a key factor that maximizes system availability.

As shown in Table I, the reliability of the system is initially at 0.6748. After increment in iterations/ epochs, the weights of synapses used as failures/ repairs are modified, using gradient descent method of back propagation of neural networks. The reliability of system attains up to 0.99 in 968 iterations with 10^{-4} tolerance. The iteratively improvement in reliability of the system reveals the importance of the BPNN technique especially in the complex engineering system.

On examination the results of Equation (34) of profit function that represents in Table II and graphically in Figure 6. It steadily increases with respect to iterations. One can also depict the comparison of profit with different values of repair cost. One can easily read the table II, when repair cost is less i.e. 30 units, profit function has maximum value each time/epochs which can stimulate operational managers to make the decision.

Therefore, the neural networks technique for optimizing the output can be an adequate and efficient way to compute as well as improve the reliability parameters of the system using the learning and updating weight mechanism.

The analysis done in this paper ensures that neural network approach helps in attaining system reliability with high precision. Hence it enhances reliability and reinforce the system utility for real time applications.

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